miniXS Evolution: The Fast Track from Gadget to GU-Ready Instrument Jerry Seidler (seidler@uw.edu)

- Undergrads: Brian Dickinson, Matt Haave, John Krah
 Grad Students: Ken Nagle , Joe Bradley
- Collaborators: Yuming Xiao & Paul Chow (HP-CAT), Mali Balasubramanian (APS), Anatoly Frenkel & Bruce Ravel (BNL), Doug Pease (UConn), Shelly Kelley & Simon Bare (UOP), Stosh Kozimor & Steve Conradson (LANL), Jeremy Kropf & Deborah Myers (ANL), John Quintana & Brian Rusthoven (APS)
- APS and Beamline staff: Steve Heald, Dale Brewe (APS), Robert Gordon (SFU)
- \$: DOE, Bosack&Kruger Foundation, ONR

What can you learn from this experiment?

$$E_{0} = \hbar \omega_{0}$$

$$\vec{k}_{0}$$

$$\vec{k}_{f}$$

$$E_{f} = \hbar \omega_{f}$$

sample (sample*)

$$\vec{q} = \vec{k}_f - \vec{k}_0$$
$$\omega = \omega_0 - \omega_f$$

What can you learn from this experiment?

(from weakest to strongest at 10 keV incident photons...)

- 'Incoherent' scattering:
- map momentum-space electronic wave function
- dynamics: local electronic structure, plasmons, phonons, ...
 'Elastic' scattering:
- relative atomic placement, nearest neighbor distances, full xtal structures...
- Photoelectric processes:
- x-ray absorption spectroscopies
- -fluorescence mapping
- x-ray emission spectroscopies
- resonant inelastic x-ray scattering (RIXS)



(Nonresonant) K α : some sensitivity to valence and spin





(Nonresonant) K β : Srong sensitivity to ion spin, also sensitivity to valence (for light TM) and bonding (for heavier TM)



(Nonresonant) K β 2,5: valence band XES – probe of occupied states near EF. Natural complement to XANES pre-edge studies



(Nonresonant) K β '': ligand semicore XES – energy is a direct fingerprint of the ligand species: useful in metalloprotien, catalysts...

What does the signal look like?



From: Glatzel, et al., 2002

What about RXES/RIXS?

- Greatly suppressed broadening from core-hole effects (what is fundamental limit on experiment sensitivity?)
- Outstanding sensitivity to crystal field and atomic configurational effects (when does the 'valence' of an atom in a solid mean anything?)
- Resonant enhancement of incoherent scattering (so far, only 'hard' stuff: magnons, charge transfer excitations – we're about to try 'easy' stuff...)



XES should be easy...

For elements S and heavier, cross-section is >90% photoelectric from 3-30 keV.

Branching fraction for x-ray emission is 5-90%

One SBCA collects 0.5 10⁻³ solid angle

SBCA intrinsic resolution is $10^{-2} - 10^{-5}$ of relevant energy band

→ Concentrated samples can have ~M-counts/sec in nonres XES studies with <1 eV resolution

...but it hasn't been easy.

- Very few hard x-ray XAS beamlines perform ~1 eV resolution XES with any regularity (exception: Fe Kb at DAC facilities)
- Severe, historic underutilization of XES as a scientific tool in its own right and as a complement to XAS
- The problem: the 'traditional' spectrometers are big, mechanically complex, somewhat pricey, require specialized optics, etc...



August 2008: \$100 'gadget' beats a large XES spectrometer for energy resolution and collection efficiency for Mn K β (Dickinson, GTS, et al, Rev Sci Instrum 2008)



June 2010: The GU-commissioned 'miniXS' at the APS 20-ID microprobe endstation. GTS, R.A. Gordon, John Quintana, Brian Rusthoven, et al., in prep.



- No moving parts (except sample translator).
- Small, portable, and cheap ('box' is 6 inches square).
- [Variants for compatibility with DAC, fridge, etc...]



This instrument has the same net collection efficiency as the largest 'traditional' XES spectrometers ever constructed.

- Why measure X-ray Emission Spectra?
- *How to (usually) Measure X-ray Emission Spectra?*

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- A miniXS survey
 - One crystal is all you need: U *M*-edge
 - New results for multi-crystal instrument design
 - Separation of overlapping emission lines: V Kβ and Cr Kα
 - F Kβ: DAC magnetism, Fuel Cell membranes
 - A truly general-purpose miniXS: 4-10 keV resonant and nonresonant XES using 3-D printing of optics

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 - Conclude & Future Directions
 - Every XAS microprobe can easily incorporate 1-eV resolution XES into detector suite
 - All plastic spectrometers for ease of compatibility with environmental cells
 - Detector limitations: more pixels, smaller pixels → huge collection solid angles and better energy resolution

How do you measure hard x-ray XES with good (to very good) energy resolution?

Two routes*, with very similar starting points and end-points.

1.(diced) Spherically bent crystal analyzer2.Multi-crystal 'miniXS'

A Very Incomplete Historical Survey of (usual) Hard X-ray Spectrometer Design



LERIX: PNC-XOR, sector 20 APS (Tim Fister, GTS, et al, Rev. Sci. Inst. 2006)



q-dependent nonresonant IXS
19 Spherically-bent Si 111 wafers
Total solid angle for 19 SBCA is ~1.2% of 4π sr





From: J.A. Bradley, GTS, G. Cooper, A. Hitchcock, M. Vos, et al, PRL **2010**

• Comparison of nonresonant IXS and EELS for N2 gas

•Extreme divergence of results when leaving the dipole scattering limit

• Direct evidence for violation of first Born approximation in qdependent EELS, even for high (multi-keV) beam energies

LERIX-2 design progress...



*Trimetric

180 analyzers.... Working on several different strategies for detector configurations

Diced, Curved Analyzers (1986?)



Unlike older bent-crystal analyzers, the top surface of the 'cube' crystal elements is unstrained → very high energy resolution.

"Dispersion Compensation" (S. Huotari, *et al*, JSR 2005 & RSI 2006)

- Energy resolution is (nearly) determined by unstrained, intrinsic response of diffracting material
- Energy bandpass on focal
 plane is determined by size
 of diced elements
- Allows high resolution with much shorter working distance -> vastly larger collection solid angle.



"Dispersion Compensation" (S. Huotari, *et al*, JSR 2005 & RSI 2006)

- 1. 'magic' ray-tracing
 - . zero-noise camera
- 3. small spot size
- 4. Resulting (smallish) energy range is OK fit with many (most) very high resolution experiments: you never want super-high energy resolution over a large energy transfer range



A "The evolution



Flatattalal Spatcometer, LargegeoSmuece sizeze, Ofmpipiztel dedettoror

Rowland Flat Xtal Circle Spectrometer, focused beam, zero-noise camera (and nice software...) Diced Dispersion Shany *idention* Dispersion Spectrometer for the second beam, zero-noise camera (and nice software...)

A "convergent" evolution



Flat xtal Spectrometer, Large Source size, One-pixel detector





Many *identical* Flat xtal Spectrometer, focused beam, zero-noise camera and *Exact* dispersion compensation

Ce L α miniXS

- •4/2010 at 20-ID
- •10 SBCA equiv
- •5.5 cm diameter Rowland circle
- •RA Gordon and TK Sham: studies of mixed valent Ce compounds
- •Resolution <0.8 eV



Spectrometer calibration



Spectrometer calibration





CeF₃ Lα XES exposure 4 minute expose 500k counts in Lα1, 2M counts in entire energy range





We've made an easy experiment easy.

Huge range of applications:

- Actinide science: new look at charge transfer excitations
- Basic QM: what does 'multiconfig' mean for f-electron materials?
- Basic CM science: metal insulator transition 'intrinsic' or 'percolative'?
- Biophysics: time resolved studies of photosynthesis
- Biophysics: what is bonded to the metal site in metalloprotiens?
- Battery research: charge transfer upon lithiation